

PDP SPMTM

FVP12030IM3LEG1 Energy Recovery

Feature

- Use of high speed 300V IGBTs with parallel FRDs
- · Single-grounded power supply by means of built-in HVIC
- Sufficient current driving capability for IGBTs due to adding a buffer
- Isolation rating of 1500Vrms/min.
- Low leakge current due to using an insulated metal substrates

Applications

• Energy Recovery Part of a PDP (Plasma Display Panel)

General Description

It is an advanced smart power module(SPMTM) that Fairchild has newly developed and designed to provide very compact and optimized performance for the energy recovery circuit of PDP driving system. It combines optimized circuit protection and drive matched to low-loss and high speed IGBTs. Under voltage lock-out protection function enhances the system reliability . The high speed built-in HVIC provides opto-couplerless single power supply IGBT gate driving capability that futher reduce the overall system size of PDP sustaining boards.

Package Outlines



Figure 1.

Pin Configurations

Top View

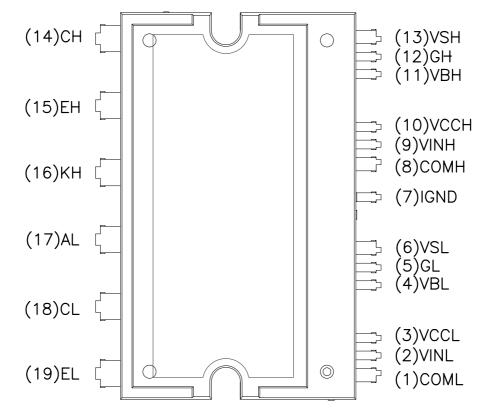


Figure 2.

Pin Descriptions

Pin Number	Pin Name	Pin Descriptions	
1	COML	Low-side Signal Ground	
2	VINL	Low-side Signal Input	
3	VCCL	Low-side Supply Voltage for HVIC	
4	VBL	Low-side Floating Supply Voltage for Buffer IC and IGBT Driving	
5	GL	Low-side Gate	
6	VSL	Low-side Floating Ground for Buffer IC and IGBT Driving	
7	IGND	IMS Ground	
8	COMH	High-side Signal Ground	
9	VINH	High-side Signal Input	
10	VCCH	High-side Supply Voltage for HVICg	
11	VBH	High-side Floating Supply Voltage for Buffer IC and IGBT Driving	
12	GH	High-side Gate	
13	VSH	High-side Floating Ground for Buffer IC and IGBT Driving	
14	СН	High-side IGBT Collector	
15	EH	High-side IGBT Emitter	
16	KH	High-side Diode Cathode	
17	AL	Low-side Diode Anode	
18	CL	Low-side IGBT Collector	
19	EL	Low-side IGBT Emitter	

Internal Equivalent Circuit and Input/Output Pins (Bottom View)

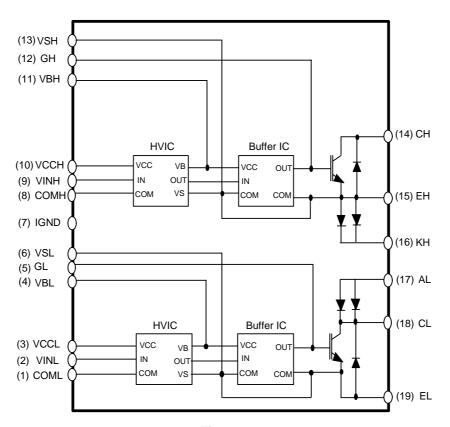


Figure 3.

Absolute Maximum Ratings ($T_C = 25^{\circ}C$, Unless Otherwise Specified)

Symbol	Parameter Conditions		Rating	Units
VCC	Control Supply Voltage	Applied between VCCL-COML, VCCH - COMH	20	V
VBS	Control Bias Voltage	Applied between VBL - VSL, VBH - VSH	20	V
VIN	Input Signal Voltage	Applied between VINL-COML,VINH - COMH	-0.3~17	V

Symbol	Parameter	Conditions	Rating	Units
VCE	Collector to Emitter Voltage	Between CL to EL, Between CH to EH V _{GH-EH} =V _{GL-EL} =0V , I _{CH} =I _{CL} =250μA	300	V
VRRM	Peak Repetitive Reverse Voltage	Between KH to EH, Between CL to AL I _{AH} =I _{AL} =250μA	300	V
VIXIXIVI	Teak Nepellive Neverse voltage	Between CH to EH, Between CL to EL $I_{AH}=I_{AL}=250\mu A$	300	V
VIN	Input Signal Voltage	VINL, VINH	-0.3 to VCC+0.3	V
I _C	Collector Current Continuous	Between CL to EL, Between CH to EH	120	Α
I _{F(AV)}	Average Rectified Forward Current	Between EH to KH, Between AL to CL per diode	30	А
. (*)		Between EH to CH Between EL to CL	10	Α
I _{CP}	Pulsed Collector Current Between CL to EL, Between CH to EH (Note1)		300	А
		Between EH to KH, Between AL to CL(Note1)	300	Α
I _{FP}	Pulsed Diode Current	Between EH to CH Between EL to CL per diode (Note1)	100	А

Notes:

^{1.} Pulse Width = 100μsec, Duty = 0.1; half sine wave *Icp limited by MAX Tj

Symbol	Parameter	Conditions	Rating	Units
	IGBT Dissipation	Tc=25°C per IGBT	117	W
Pd	IGBT Dissipation	Tc=100°C per IGBT	47	W
Pa	EDD Discipation	Tc=25°C per diode	109	W
	FRD Dissipation	Tc=100°C per diode	43	W
Tj	Operating Junction Temperture		-20 ~ 150	°C
T _C	Module Case Operation Temperature		-20 ~ 125	°C
T _{STG}	Storage Temperature		-40 ~ 125	°C
V _{ISO}	Isolation Voltage	60Hz, Sinusoidal, AC 1 minute, Connection Pins to IMS substrate	1500	V _{rms}

Thermal Resistance

Symbol	Parameter	Conditions	Min.	Max.	Units
		Between CH to EH, Between CL to EL Per IGBT	-	1.07	°C/W
R _{th(j-c)}	Junction to Case Thermal Resistance	Between EH to KH, Between AL to CL	-	1.15	°C/W
	. 100.010.1100	Between CH to EH, Between CL to EL Per Diode	-	3.70	°C/W

$\textbf{Electrical Characteristics} \ \, (T_C = 25^{\circ}\text{C, Unless Otherwise Specified})$

Symbol	Parameter	Conditions		Min.	Тур.	Max.	Units
I _{QCC}	Quiescent VCC Supply Current	VCC = 15V VINL, VINH = 0V	VCCL-COML, VCCH-COMH	-	-	100	μА
I _{QBS}	Quiescent VBS Supply Current	VBS = 15V VINL, VINH= 0V	VBL- VSL, VBH- VSH	-	-	500	μА
UV _{BSD}	Supply Circuit Under Voltage Protection	Detection Level		10.1	11.3	12.5	V
UV _{BSR}		Reset Level		10.5	11.7	12.9	V
VIN _(ON)	ON Threshold Voltage	Applied between VINL-COML ,VINH - COMH		3.0	-	-	V
VIN _(OFF)	OFF Threshold Voltage	Applied between VINL-COML, ,VINH - COMH		-	-	0.8	V

Symbol	Parameter	Cond	lition	Min.	Тур.	Max.	Units
	IGBT Collector-Emitter	VCC = VBS = 15V	I _C = 25A, T _J = 25°C	-	-	1.4	V
$V_{CE(SAT)}$	Saturation Voltage	VIN = 5V	I _C = 120A, T _J = 25°C	-	1.9	-	V
.,,	Diode Forward Voltage	Between CL to AL Between KH to EH	I _F =30A, T _J = 25°C	-	-	1.4	V
V _F	Diode Forward Voltage	Between EH to CH Between EL to CL	I _F =10A, T _J = 25°C	-	-	1.7	V
td _{ON}		VCE=200V, VCC= VBS=15V			230		ns
t _r	Switching Times	Ic = 20A	/IN = 0V 5V , Inductive Load		55		ns
td _{OFF}	- Switching times	$T_c = 25^{\circ}C$			270		ns
t _F		(Note2)			48		ns
I _{CES}	IGBT Collector-Emitter Leakage Current	V _{CE} = 300V		-	-	250	μА
ı	Diode Anode-Cathode	Between CL to AL Between KH to EH	VAnode-Cathode=300V			250	μА
I _R	Leakage Current	Leakage Current Between EH to CH Between EL to CL VAnode-Cathode=300V	-	-	250	μА	

Notes

^{2.} $t_{\mbox{ON}}$ and $t_{\mbox{OFF}}$ include the propagation delay time of internal drive IC. For the detailed information, please see Figure 4.

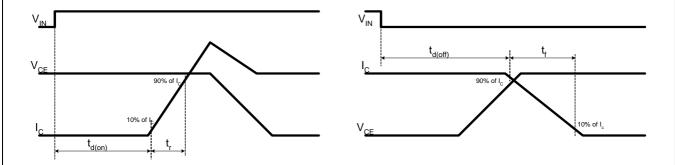


Figure 4. Switching Time Definition

Typical Performance Characteristics

Figure 5. Typical Output Characteristics

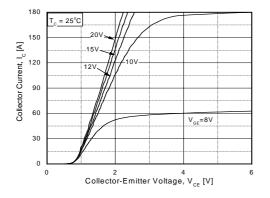


Figure 7. Typical Forward Voltage Drop

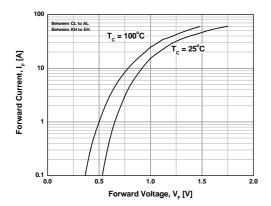


Figure 9. FBSOA

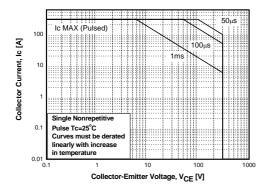


Figure 6. Typical Output Characteristics

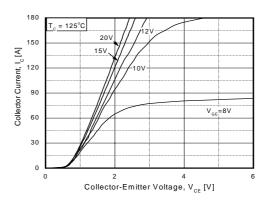
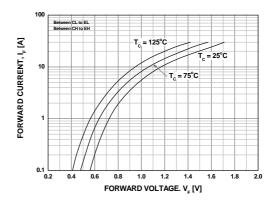


Figure 8. Typical Forward Voltage Drop



Mechanical Characteristics and Ratings

Parameter	Co	nditions	Limits			Units
Parameter	Co	Conditions			Max.	
Mounting Torque	Mounting Screw: - M3	Recommended 0.62N•m	0.51	0.62	0.72	N•m
Device Flatness		Note Figure 5	0	-	+100	μm
Weight			-	13.4	-	g

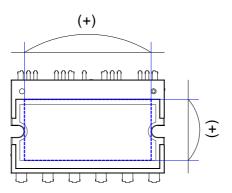


Figure 10. Flatness Measurement Position

Detailed Package Outline Drawings 0.60±0.10 (3.000) 19x2.00±0.10=38.000 (0.70) (0.70) 3.10±0.05 Package Center 1.50±0.10 1.00 NO 13 (4-ø1.5 Dp0.10) NO 14 NO 19 5.50±0.10 *L1 5.60±0.20 (34.50) 40.00±0.10 44.00±0.10 (2.95) 5x7.62±0.10=38.10 (0.85) (0.80) Max3.20 Figure 11.





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Rev. I24